Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,291	FUKAZAWA ET AL.	
Examiner	Art Unit	
Jack Dinh	2873	

SEARCHED				
Class	Subclass	Date	Examiner	
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TNI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Restricted the claims.	5/21/2006	JD	
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